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## **APPENDIX 3: Photographs of test setup**

#### **Conducted Emission**

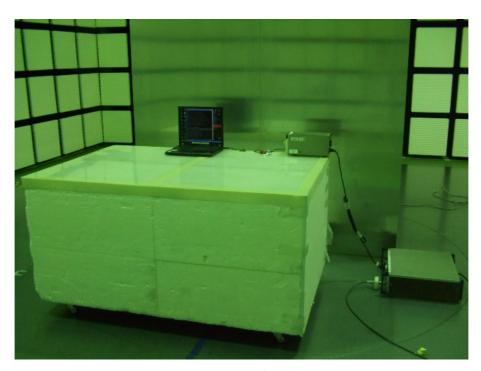


Photo 1

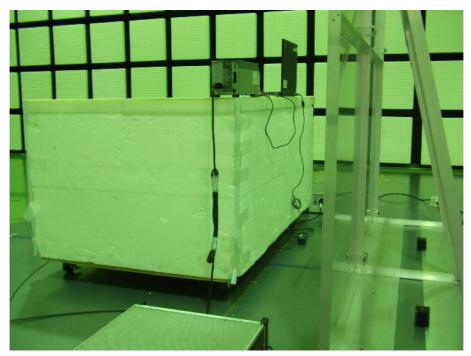


Photo 2

## UL Japan, Inc.

#### **Head Office EMC Lab.**

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116 Facsimile : +81 596 24 8124

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## **Radiated Spurious Emission**

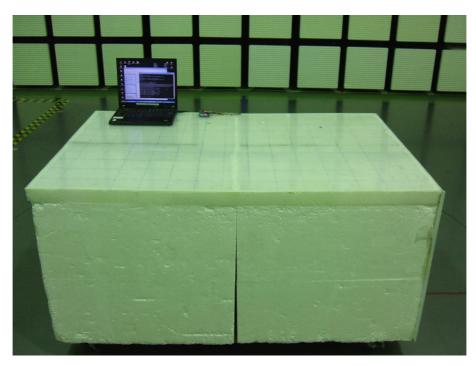


Photo 1

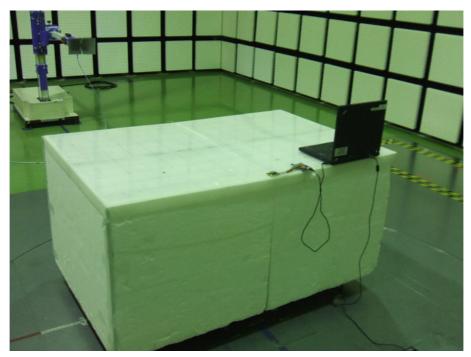


Photo 2

# UL Japan, Inc.

#### **Head Office EMC Lab.**

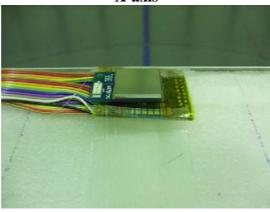
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116 Facsimile : +81 596 24 8124

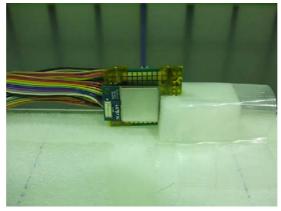
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## Worst Case Position (Horizontal: Y-axis/ Vertical: X-axis)

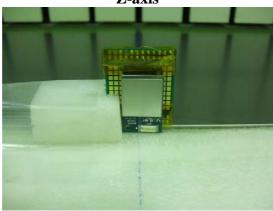
## X-axis



Y-axis



**Z**-axis



**Head Office EMC Lab.** 

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116 Facsimile : +81 596 24 8124